

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
30V	18mΩ@10V	6A
	24mΩ@4.5V	
-30V	30mΩ@-10V	-6A
	45mΩ@-4.5V	

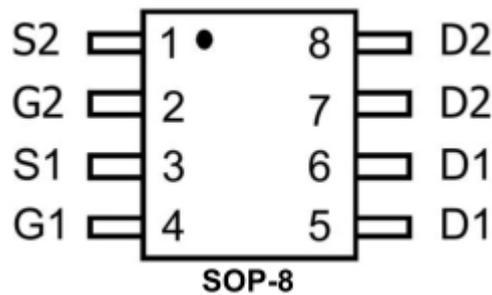
Feature

- TrenchFET Power MOSFET
- Excellent $R_{DS(on)}$ and Low Gate Charge

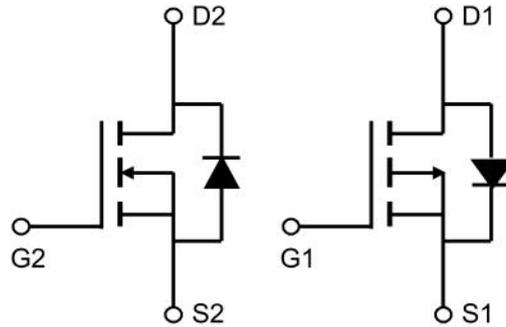
Application

- Load Switch for Portable Devices
- Battery Switch

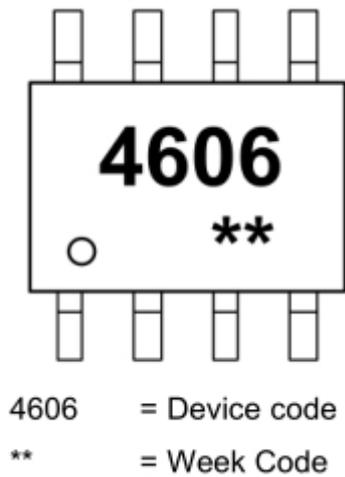
Package



Circuit diagram



Marking



Absolute maximum ratings

($T_a=25^{\circ}\text{C}$ unless otherwise noted)

Parameter	Symbol	Value		Unit
		N-Channel	P-Channel	
Drain-Source Voltage	V_{DS}	30	-30	V
Gate-Source Voltage	V_{GS}	± 20	± 20	V
Continuous Drain Current($t \leq 10\text{s}$)	I_D	6	-6	A
Power Dissipation($t \leq 10\text{s}$)	P_D	2	2	W
Thermal Resistance from Junction to Ambient($t \leq 10\text{s}$)	$R_{\theta JA}$	62.5		$^{\circ}\text{C}/\text{W}$
Junction Temperature	T_J	150		$^{\circ}\text{C}$
Storage Temperature	T_{STG}	-55~ +150		$^{\circ}\text{C}$

N-Channel Electrical characteristics

($T_A=25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV (BR) _{DSS}	$V_{GS} = 0V, I_D = 250\mu\text{A}$	30			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 30V, V_{GS} = 0V$			1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$			± 0.1	μA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1.0	1.5	2.2	V
Drain-source on-resistance	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 1A$		18	30	m Ω
		$V_{GS} = 4.5V, I_D = 1A$		24	42	
Dynamic Characteristics						
Input capacitance	C_{iss}	$V_{DS} = 15V, V_{GS} = 0V,$ $f = 1\text{MHz}$		416		pF
Output capacitance	C_{oss}			62		
Reverse transfer capacitance	C_{rss}			51		
Switching Characteristics						
Total gate charge	Q_g	$V_{DS} = 20V, V_{GS} = 4.5V,$ $I_D = 6A$		5		nC
Gate-source charge	Q_{gs}			1.11		
Gate-drain charge	Q_{gd}			2.61		
Turn-on Delay Time	$T_{d(on)}$	$V_{DD} = 12V, V_{GS} = 10V,$ $R_G = 3.3\Omega, I_D = 6A$		7.7		nS
Turn-on Rise Time	T_r			46		
Turn-Off Delay Time	$T_{d(off)}$			11		
Turn-Off Fall Time	t_f			3.6		
Source-Drain Diode Characteristics						
Diode Forward Voltage	V_{SD}	$I_S = 1A, V_{GS} = 0V, T_J = 25^\circ\text{C}$			1.2	V

Notes:

1. Pulse test: pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
2. Guaranteed by design, not subject to production testing.

P-Channel Electrical characteristics

($T_A=25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Off characteristics						
Drain-source breakdown voltage	$BV_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-30			V
Zero gate voltage drain current	I_{DSS}	$V_{DS} = -30V, V_{GS} = 0V$			-1	μA
Gate-body leakage current	I_{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0V$			± 100	μA
Gate threshold voltage ¹⁾	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-1	-1.6	-3	V
Drain-source on-resistance	$R_{DS(on)}$	$V_{GS} = -10V, I_D = -1A$		40	50	$m\Omega$
		$V_{GS} = -4.5V, I_D = -1A$		60	80	
Dynamic characteristics²⁾						
Input Capacitance	C_{iss}	$V_{DS} = -15V, V_{GS} = 0V,$ $f = 1MHz$		501		pF
Output Capacitance	C_{oss}			72		
Reverse Transfer Capacitance	C_{rss}			57		
Switching Characteristics						
Total gate charge	Q_g	$V_{DS} = -15V, V_{GS} = -6.5V,$ $V_{GS} = -10V$		16.6		nC
Gate-source charge	Q_{gs}			1.8		
Gate-drain charge	Q_{gd}			4.2		
Turn-on Delay Time	$T_{d(on)}$	$V_{DD} = -15V, R_L = 2.3\Omega,$ $V_{GS} = -10V, R_{GEN} = 6\Omega$		7.5		nS
Turn-on Rise Time	T_r			5.5		
Turn-Off Delay Time	$T_{d(off)}$			19		
Turn-Off Fall Time	t_f			7		
Source-Drain Diode Characteristics						
Body Diode Voltage	V_{SD}	$I_S = -1A, V_{GS} = 0$			-1.2	V

Notes:

1. Pulse test: pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
2. Guaranteed by design, not subject to production testing.

N-Channel Typical Characteristics

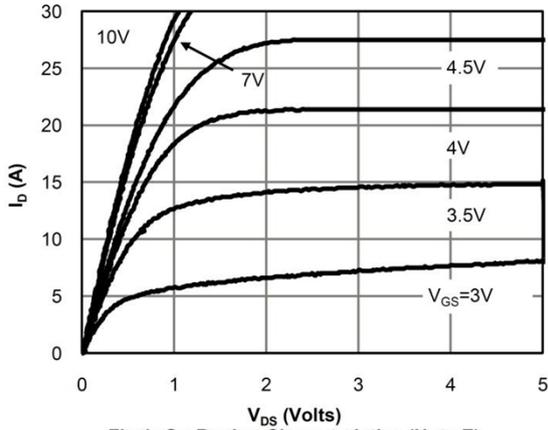


Fig 1: On-Region Characteristics (Note E)

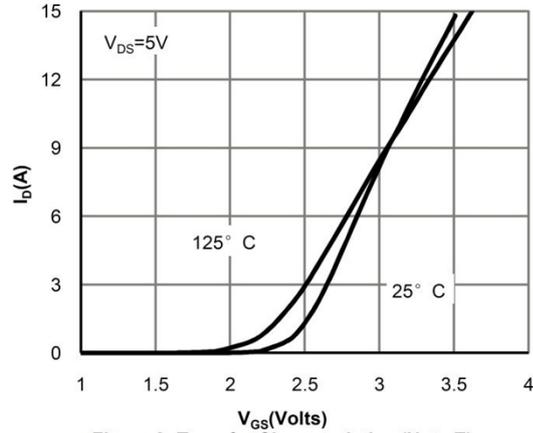


Figure 2: Transfer Characteristics (Note E)

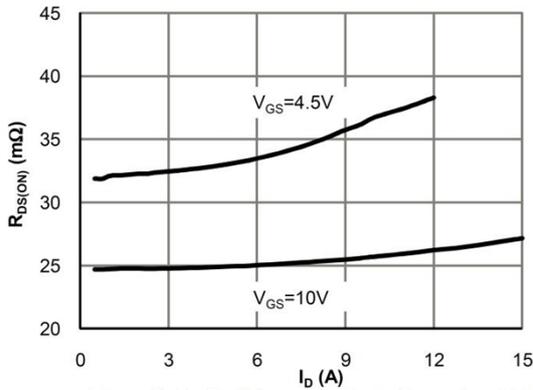


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

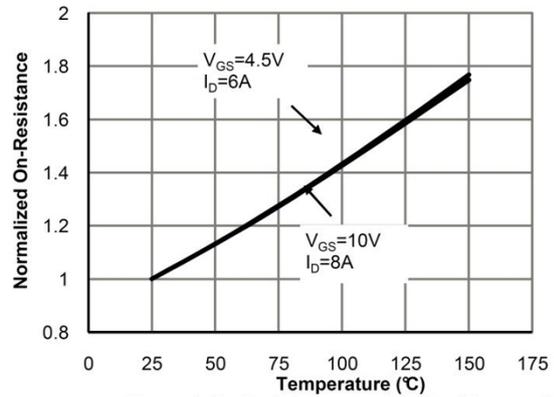


Figure 4: On-Resistance vs. Junction Temperature (Note E)

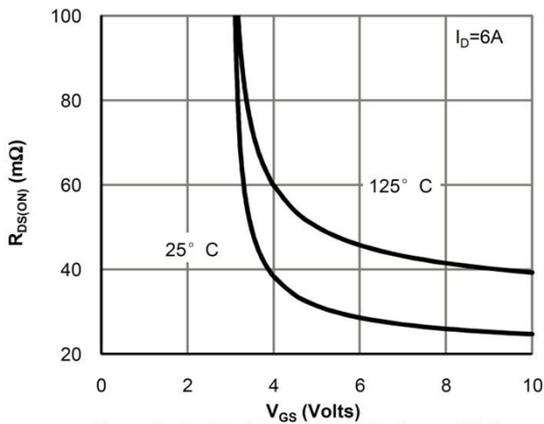


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

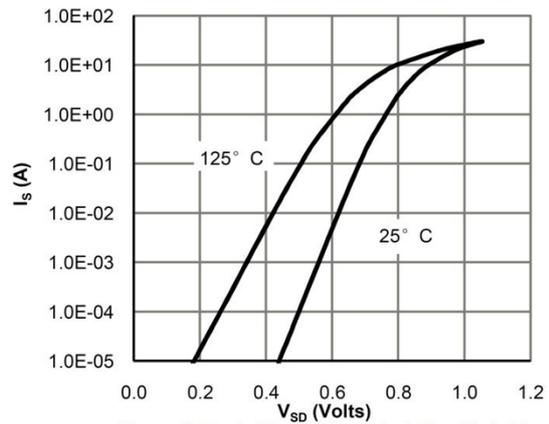


Figure 6: Body-Diode Characteristics (Note E)

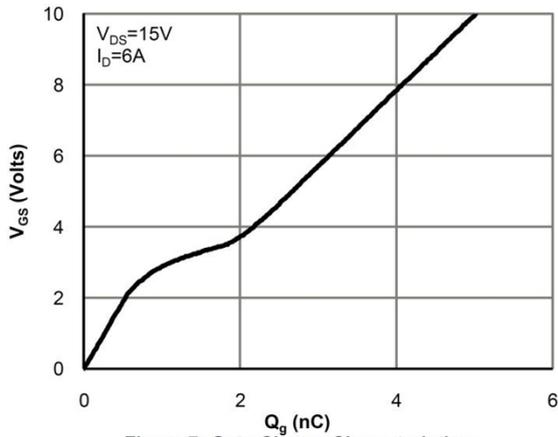


Figure 7: Gate-Charge Characteristics

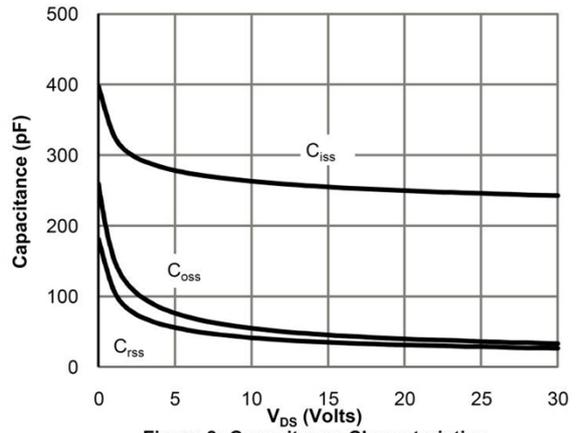


Figure 8: Capacitance Characteristics

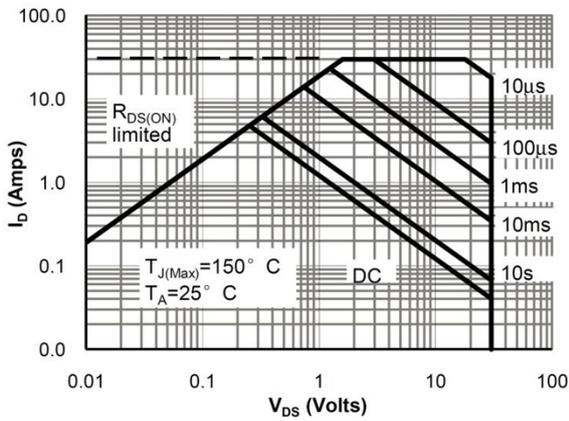


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

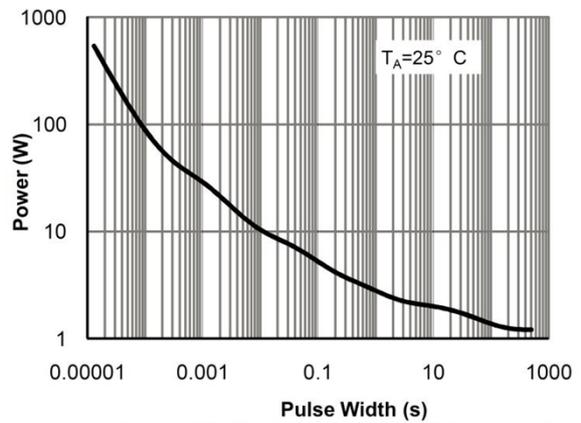


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

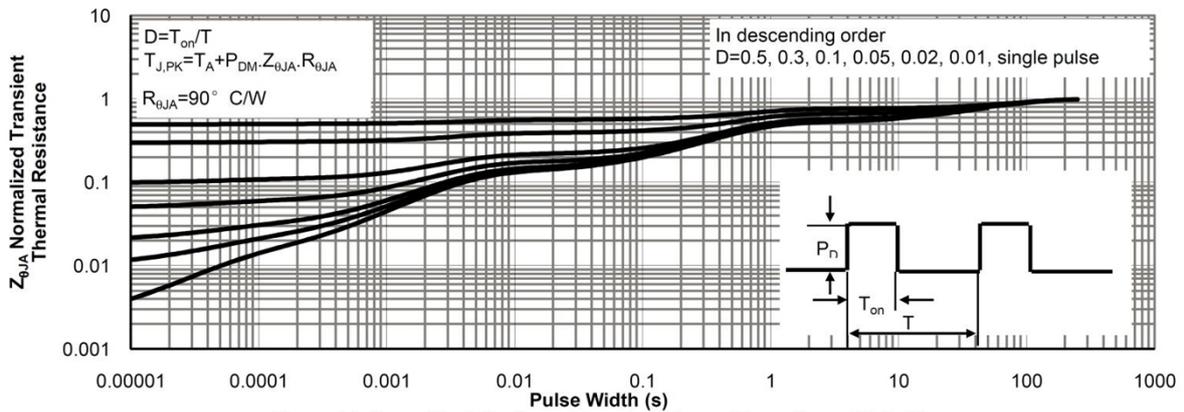


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

P-Channel Typical Characteristics

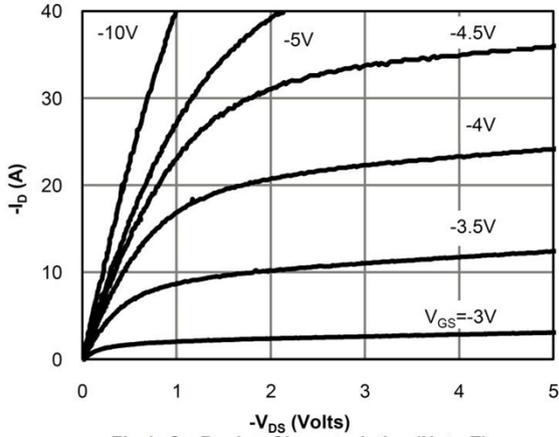


Fig 1: On-Region Characteristics (Note E)

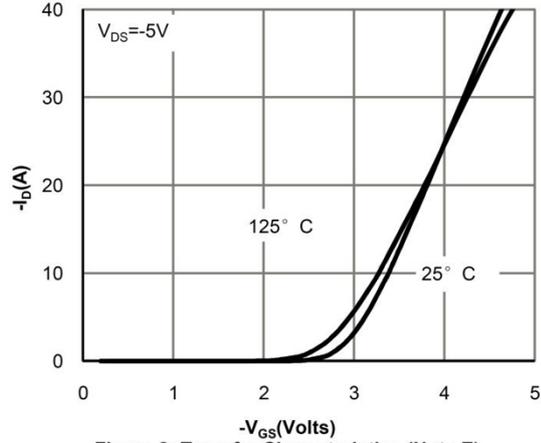


Figure 2: Transfer Characteristics (Note E)

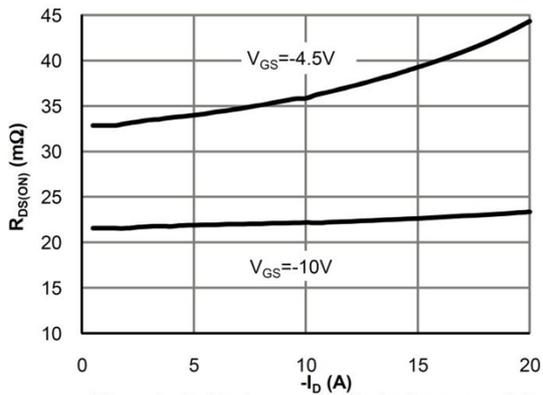


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

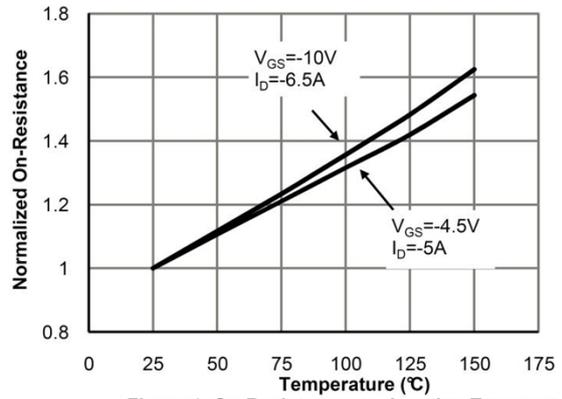


Figure 4: On-Resistance vs. Junction Temperature (Note E)

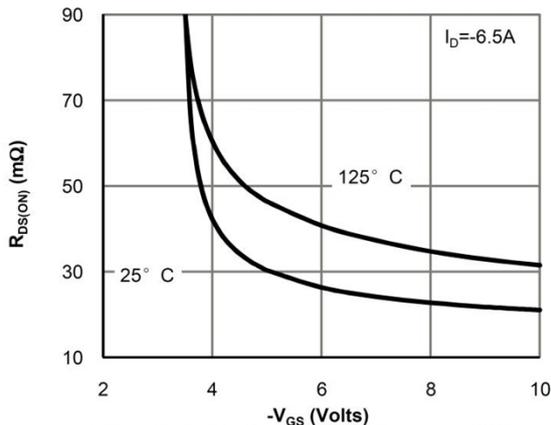


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

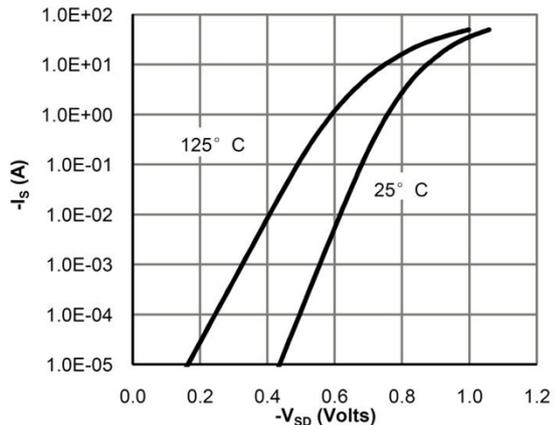


Figure 6: Body-Diode Characteristics (Note E)

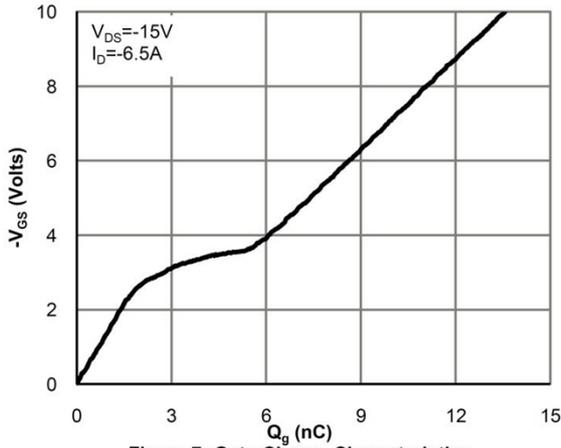


Figure 7: Gate-Charge Characteristics

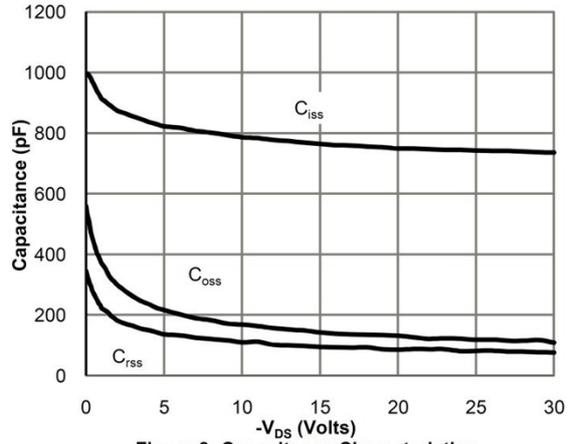


Figure 8: Capacitance Characteristics

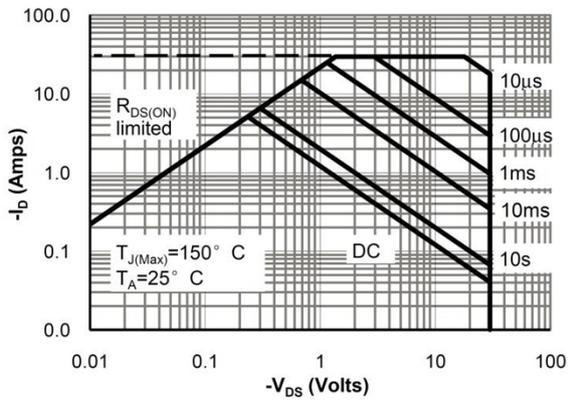


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

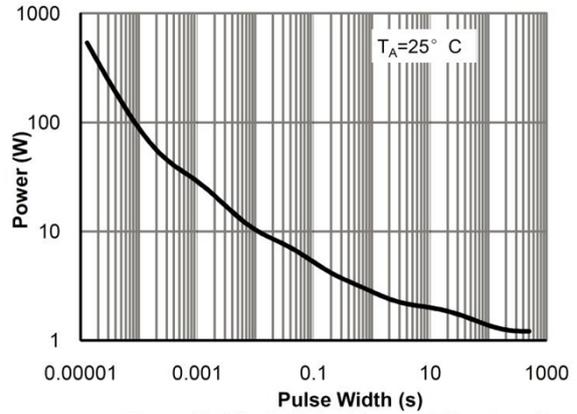


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

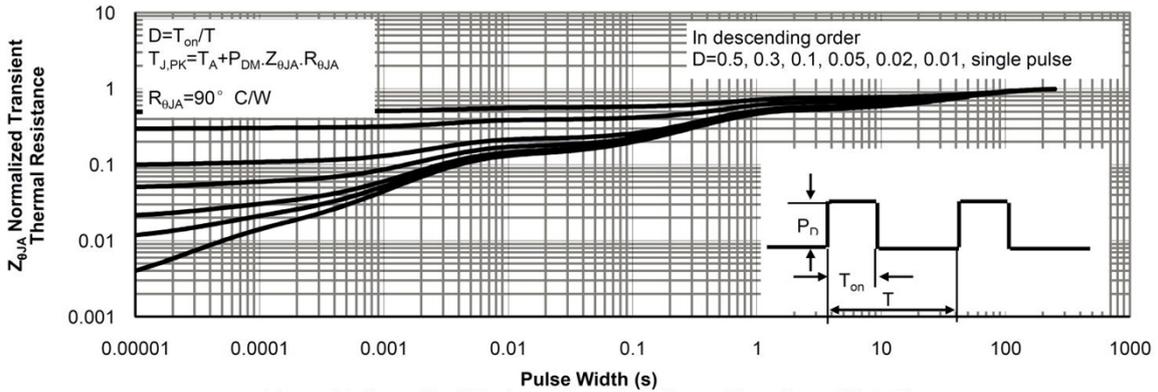
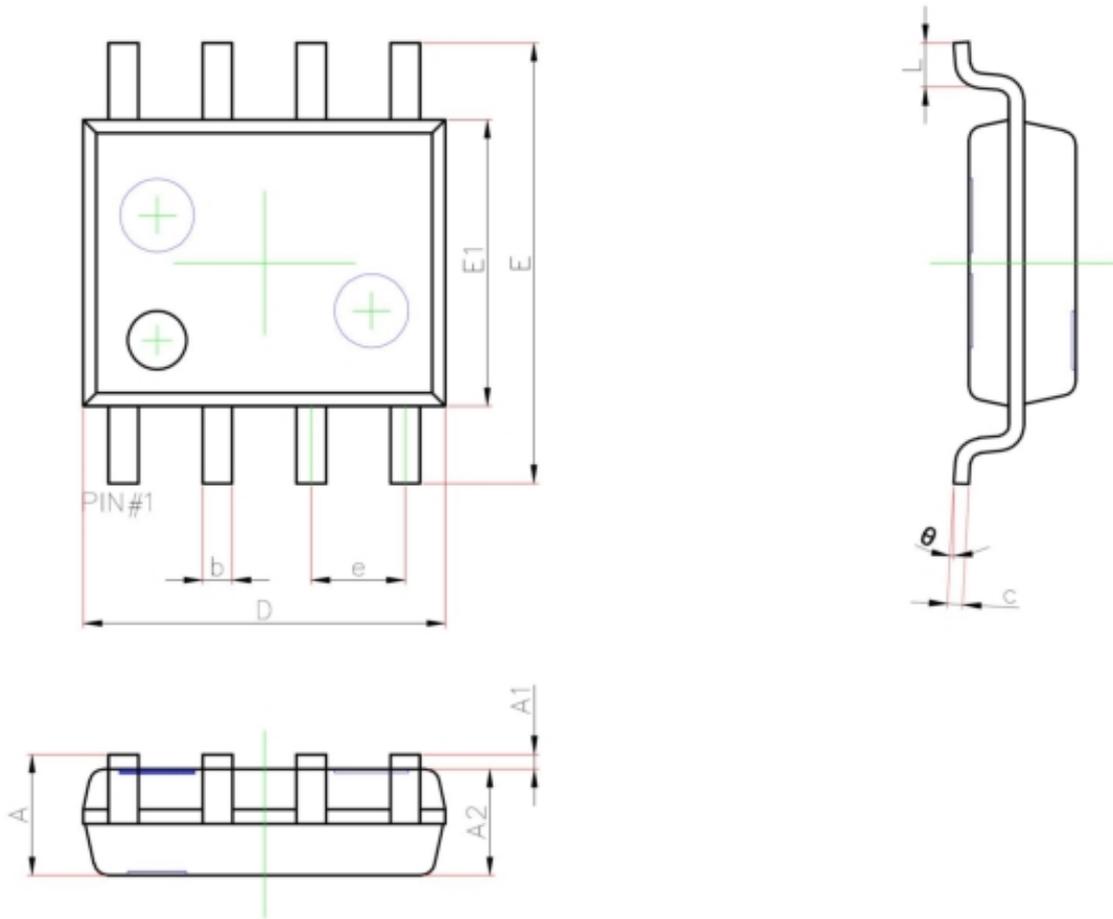


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

SOP-8 Package Information



Symbol	Dimensions In Millimeters	
	Min.	Max.
A	1.35	1.75
A1	0.10	0.25
A2	1.35	1.55
b	0.33	0.51
c	0.17	0.25
D	4.80	5.00
e	1.27 REF.	
E	5.80	6.20
E1	3.80	4.00
L	0.40	1.27
θ	0°	8°